

FIG 1



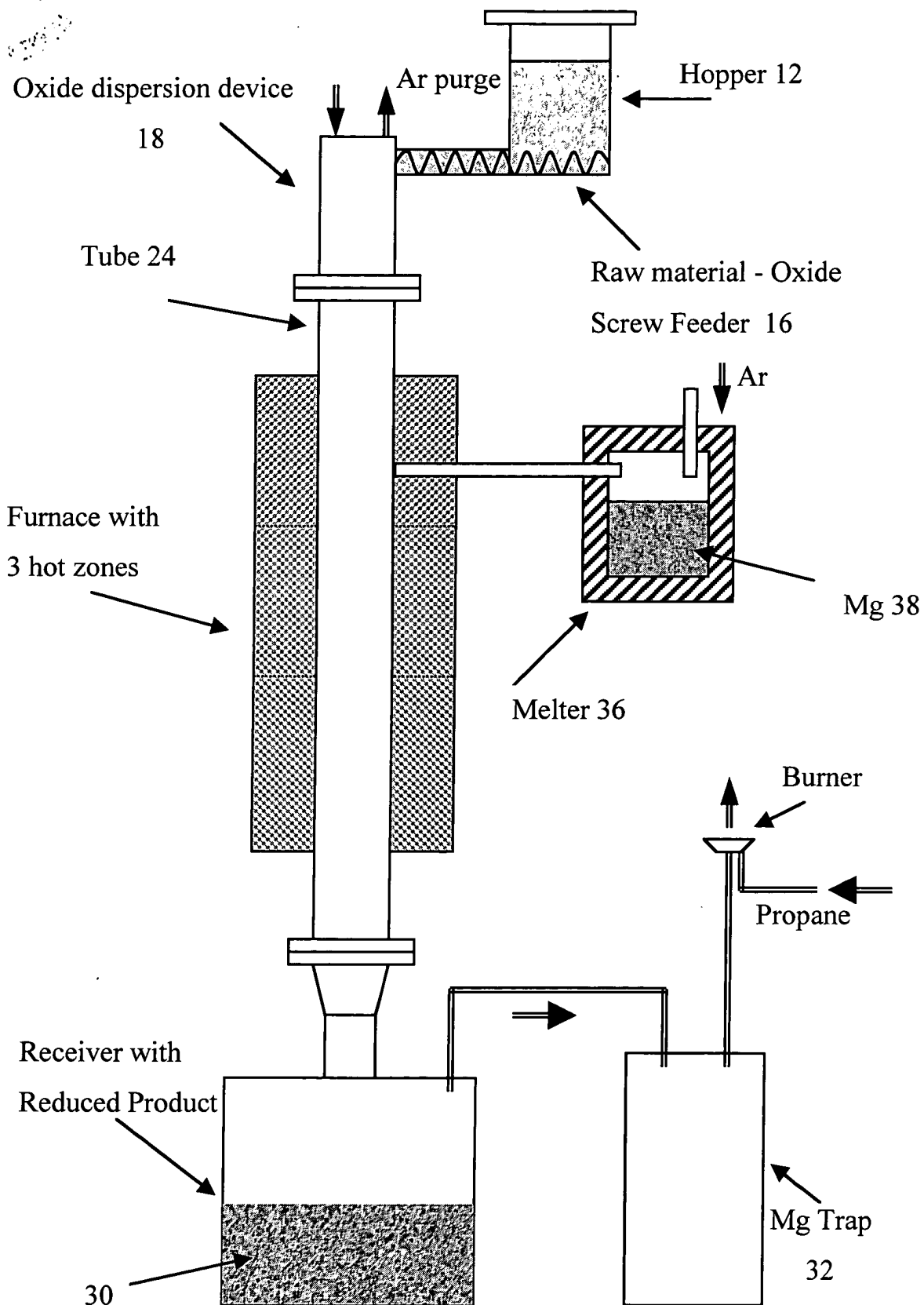


FIG 2



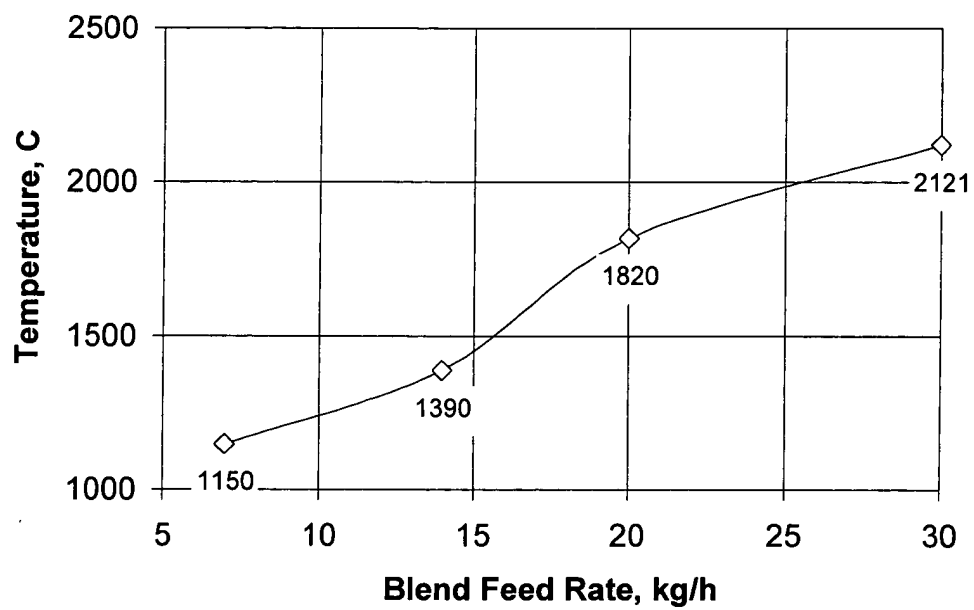


FIG. 3

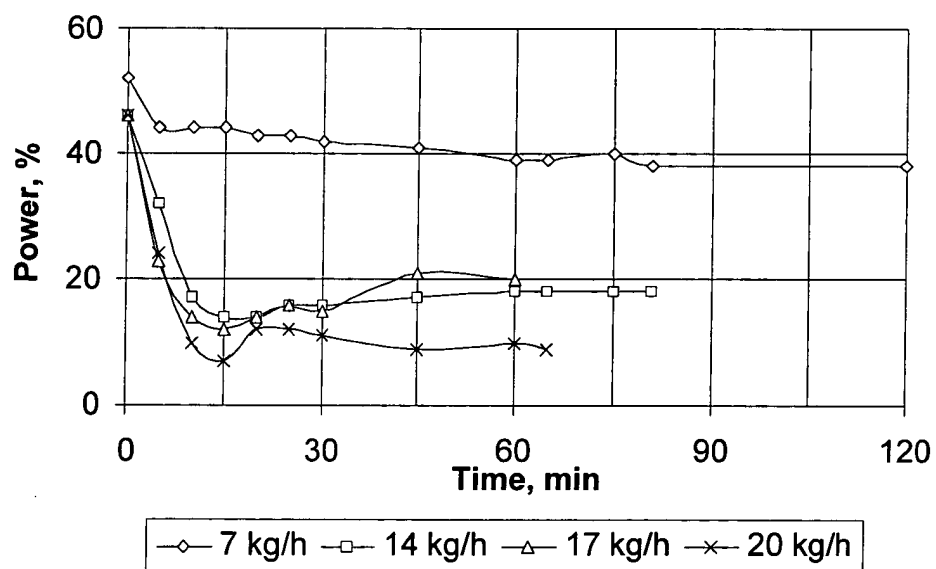


FIG. 4



A high-magnification scanning electron micrograph (SEM) showing a highly textured surface. The texture consists of a dense, regular array of small, rounded features, possibly grains or particles, separated by fine lines or grooves. The overall appearance is that of a crystalline or polycrystalline material with a fine-grained structure. The image is in grayscale, with the texture appearing as a complex pattern of light and dark spots and lines. At the bottom of the image, there is a scale bar and technical data. The scale bar is a horizontal line with the text "100 nm" below it. To the left of the scale bar, the text "SE 18KV 100000X" is displayed, indicating the imaging mode (Secondary Electron), voltage (18 kV), and magnification (100,000X).

FIG. 5



202207260000

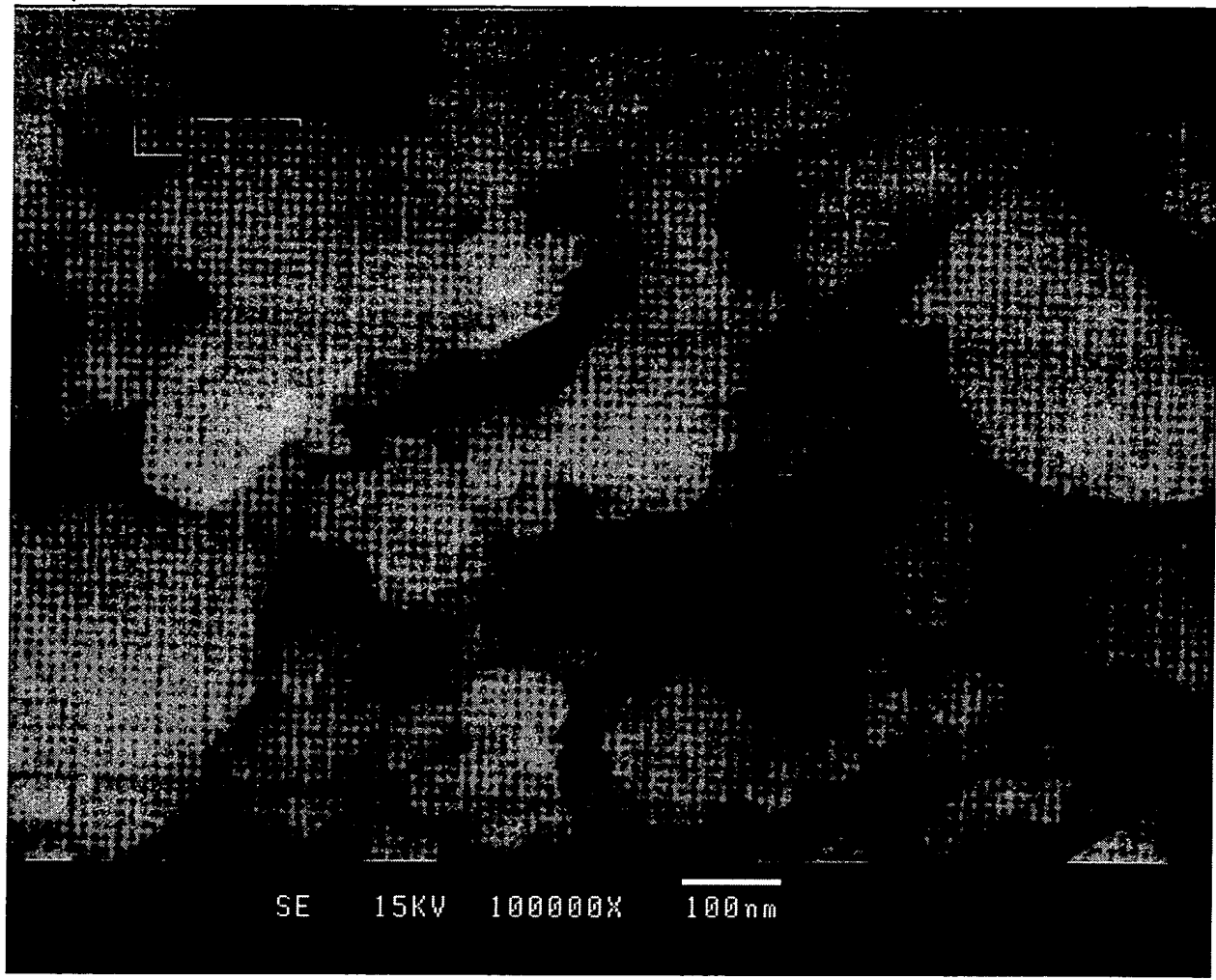


FIG. 6



402700-240500

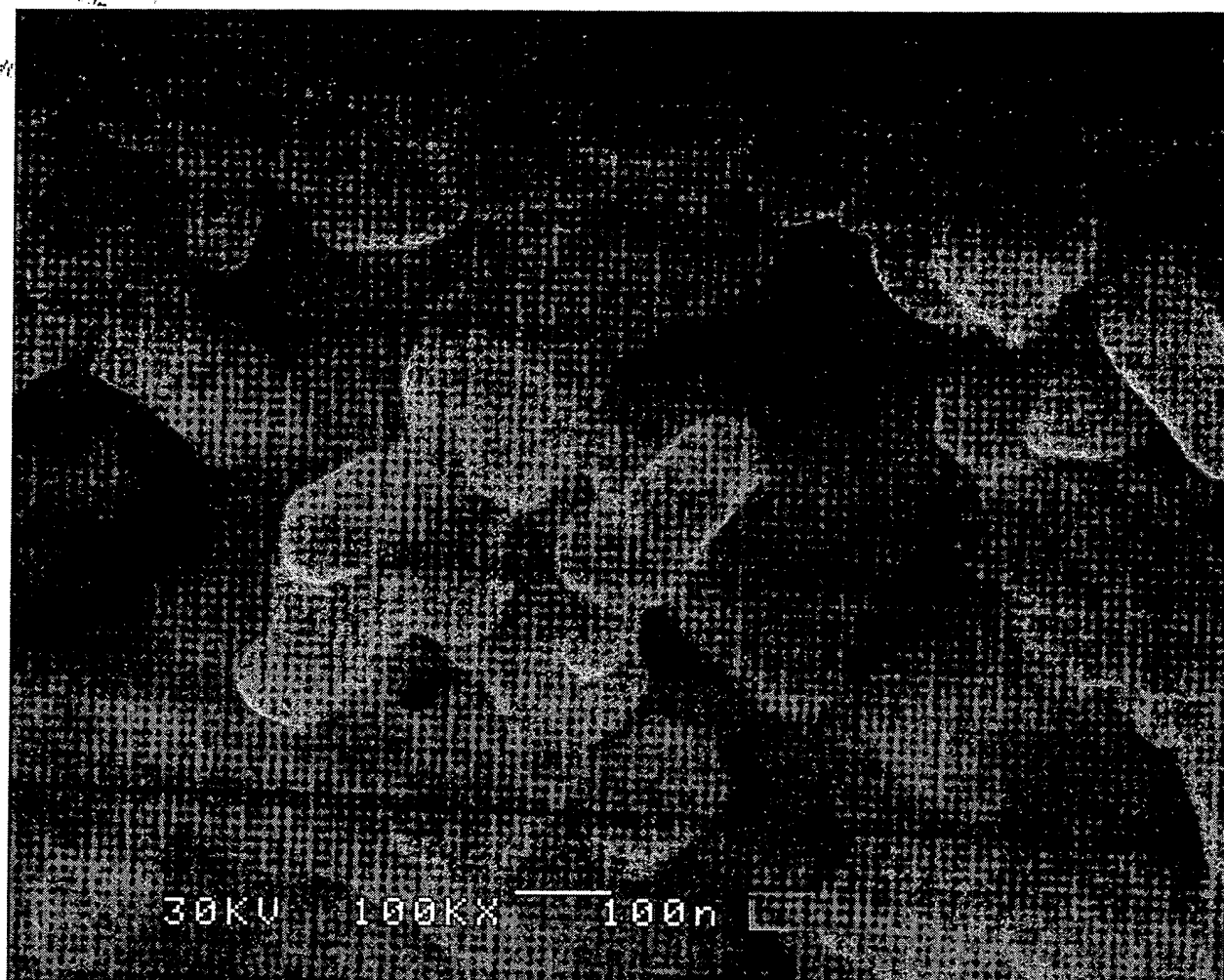


FIG. 7



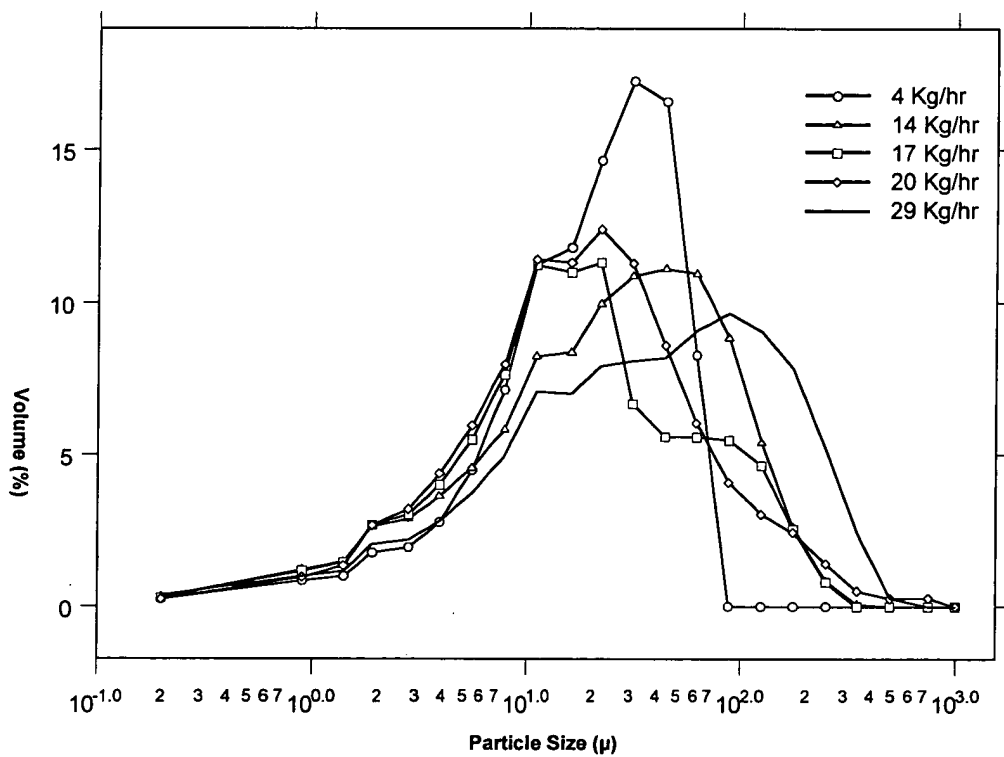


FIG. 8



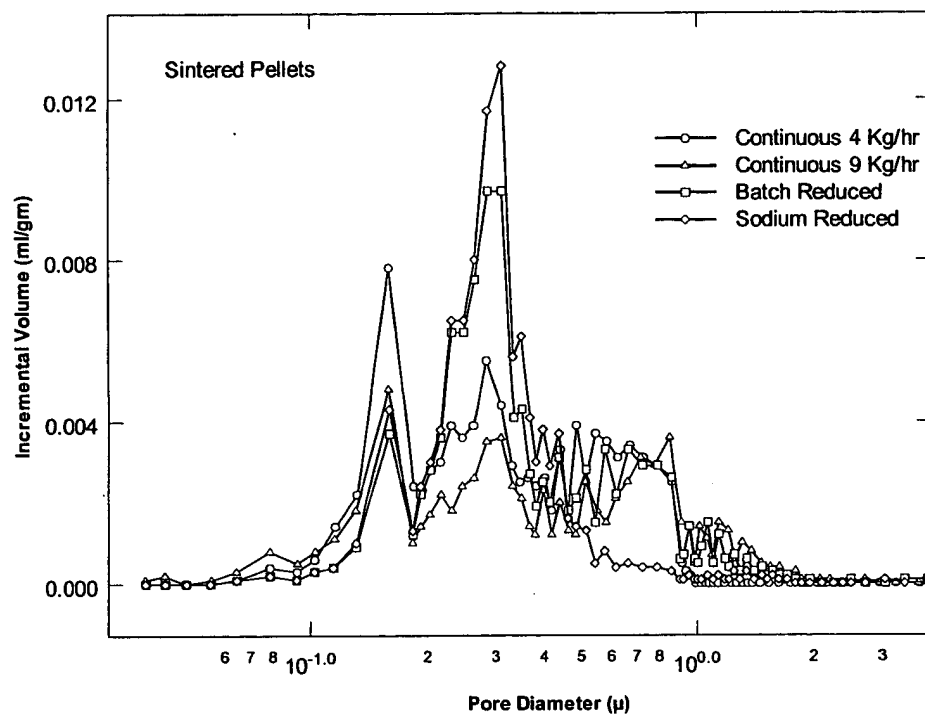


FIG. 9



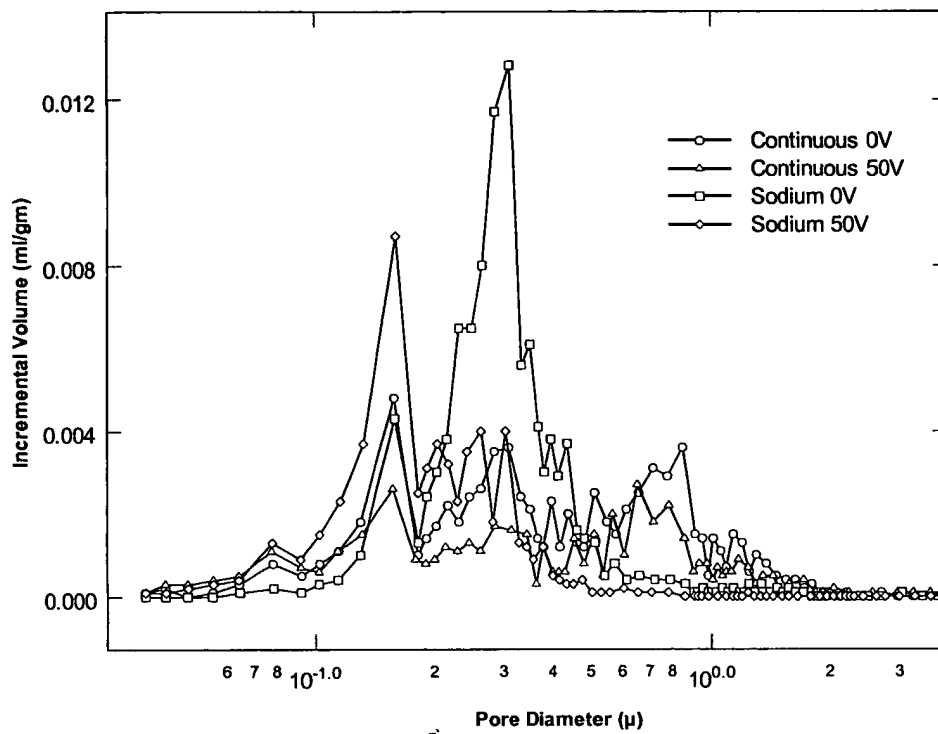


FIG. 10